

SIS Design and Development Workshop

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 Formation

 Sessions sur demande

 Attestation de présence

 Formation présentielle

 7 heures

Référence de la formation: FR-SIL SIS

Version: 28.03.2024. Vous trouverez toutes les informations actuelles sur <https://academie-fr.tuv.com/s/FR-SIL SIS>

This 2 day workshop is intended to take participants through the factors that need to be considered when performing Safety Instrumented Systems (SIS) and Safety Instrumented Function (SIF) designs for low demand process sector related applications in line with the international IEC 61508 and IEC 61511 standards.

Les objectifs

The objectives of the workshop are:

- to develop the SIS safety requirements specification (SRS) and select appropriate devices to meet the requirements
- to identify considerations for field elements (do's and don'ts)
- to implement an appropriate SIF design architecture to meet the SRS
- to perform the PFD, safe failure fraction and hardware fault tolerance calculations
- to understand and evaluate the effects of testing and maintenance on SIFs
- to understand the impact of common cause failures,
- to be able to select and use appropriate reliability data.

Le public ciblé

Engineers and systems integrators involved in the development of safety requirements specifications (SRS) and the detailed design of SIS and SIF, including verification calculations for the probability of failure on demand (PFD), Safe Failure Fraction (SFF), hardware fault tolerance and common cause failures (CCF).

Les prérequis

No prerequisites.

Le contenu de la formation

The course is focused on the design phase which is covered in considerable detail and includes the following topics:

- SIS Design and Development
- Integrity Specification of a SIF
- SIS Safety Requirements Specification
- Selection of Components and Subsystems
- Proven in Use
- Field Devices
- Failures
- Failure and Reliability
- Probability of Failure on Demand
- Demand Modes
- SIS Implementation (low demand mode)
- Importance of Testing
- Importance of Maintenance
- Fractional Dead Times
- Common Cause Failures
- Safe Failure Fraction
- Hardware Fault Tolerance
- Calculating the PFD for systems with diagnostics
- Subsystem Safety Integrity \Rightarrow Improving the PFD
- Partial Closure Testing \Rightarrow Improving Diagnostics
- Measurement Validation & Comparison \Rightarrow Reliability data

Course instruction will be complimented with examples, demonstrations and exercises to equip participants with methods and tools for SIF/SIS design and development for meeting the appropriate IEC 61508/61511 lifecycle requirements.

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Informations importantes

Si vous êtes en situation de handicap, nous vous remercions de bien vouloir nous contacter avant de procéder à l'inscription en envoyant un mail à formation@fr.tuv.com. Nous mettrons tout en œuvre pour répondre à votre besoin de formation.

If you have a disability, please contact us before registering by sending an email to formation@fr.tuv.com. We will do our best to accommodate your training needs.

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